

FORM PTO-1449
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
NIT-163-02SERIAL NO.
10/075,283**LIST OF DOCUMENTS CITED BY APPLICANT**
(Use several sheets if necessary)APPLICANT
M. IWAYAMA et alFILING DATE
February 15, 2002GROUP
2165 2165**U.S. PATENT DOCUMENTS**

* EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
AA						
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FOREIGN PATENT DOCUMENTS

	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
MAJ	AL 10-269237	10/9/1998	Japan			<input checked="" type="checkbox"/>	<input type="checkbox"/>
	AM						
	AN						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

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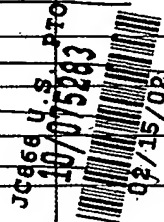

EXAMINER

DATE CONSIDERED

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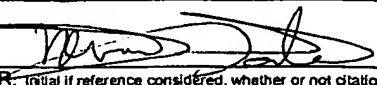
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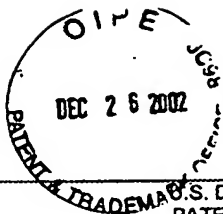
Sheet 1 of 2

FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. NIT-163-02		SERIAL NO. 10/075,283	
LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT M. IWAYAMA et al		GROUP 265	
				FILING DATE February 15, 2002			
U.S. PATENT DOCUMENTS							
* EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)	
MAJ	AA 5,590,319	12/31/96	Cohen et al				
MAJ	AB 5,987,460	11/1999	Niwa et al				
MAJ	AC 5,926,811	07/1999	Miller et al				
MAJ	AD 5,870,740	02/1999	Miller et al				
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MAJ	AL 64-74210	03/20/89	Japan			<input type="checkbox"/>	<input checked="" type="checkbox"/>
	AM 93/37499	08/27/98	WO PCT			<input type="checkbox"/>	<input type="checkbox"/>
	AN 10-74210	03/17/98	Japanese Laid-Open Patent			<input type="checkbox"/>	<input type="checkbox"/>
	AO 11-85786	03/30/99	Japanese Laid-Open Patent			<input type="checkbox"/>	<input type="checkbox"/>
↓	AP 10-254887	09/25/98	Japanese Laid-Open Patent			<input type="checkbox"/>	<input type="checkbox"/>
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
MAJ	AR	B. Velez et al, "Fast and Effective Query Refinement", Annual International ACM-SIGIR Conference on Research and Development in Information Retrieval, US, New York, NY, July 27, 1997, pp. 6-15.					
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EXAMINER 				DATE CONSIDERED 1/5/06			
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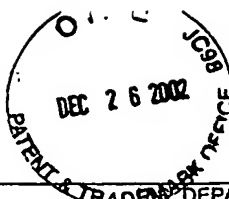
Sheet 2 of 2

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	AN						<input type="checkbox"/> <input type="checkbox"/>
	AO						<input type="checkbox"/> <input type="checkbox"/>
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				GROUP 275265		
U.S. PATENT DOCUMENTS						
* EXAMINER INITIAL		DOCUMENT	DATE	NAME	CLASS	FILING DATE (If Appropriate)
MSJ ↓	AA	5,590,319	12/31/96	Cohen et al		
	AB	5,987,460	11/1999	Niwa et al		
	AC	5,926,811	07/1999	Miller et al		
	AD	5,870,740	02/1999	Miller et al		
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FOREIGN PATENT DOCUMENTS

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						YES	NO
NB	AL 8-287103	11/01/96	Japanese Laid-Open Patent			<input type="checkbox"/>	<input type="checkbox"/>
NB	AM 9-62693	03/07/97	Japanese Laid-Open Patent			<input type="checkbox"/>	<input type="checkbox"/>
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	AP					<input type="checkbox"/>	<input type="checkbox"/>

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